

**Search Notes**

Application/Control No.

10/823,155

Examiner

Gopal C. Ray

Applicant(s)/Patent under  
Reexamination

BAILEY ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	305,306	5/30/2007	GCR
713	300,320	5/30/2007	GCR
714	47	5/30/2007	GCR
709	235,239	5/30/2007	GCR
709	240	5/30/2007	GR
370	420,437	5/30/2007	GCR
370	354,229	5/30/2007	GCR
370	235,237	5/30/2007	GCR
710	107,309	5/30/2007	↓
710	316	5/30/2007	GCR
711	147	5/30/2007	GCR
718	105	5/31/2007	GCR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PG PUB text search - see interference search printout		5/30/2007	GCR

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see serach history printouts)	5/30/2007	GCR
EAST: USPT (see serach history printouts)	5/30/2007	GCR
NPL; IEEE Xplore (see serach history printouts)	5/30/2007	GCR
consulted with Primary Examiner Paul Myers if he was aware of any prior art better than those of record	5/30/2007	GCR
EAST: US PGPUB, USPT, EPO ABS, JPO ABS (see serach history printouts)	5/30/2007	PM